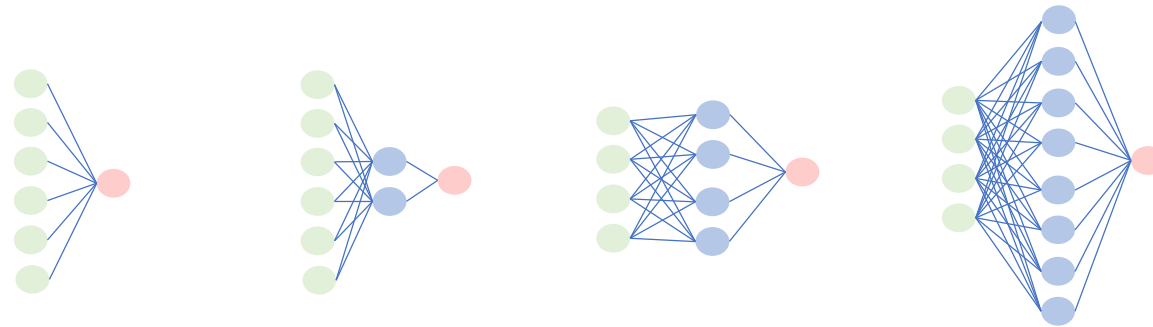
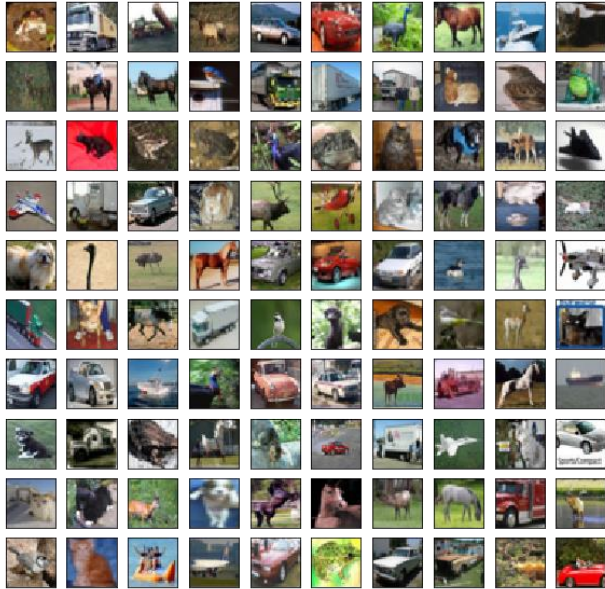


Bayes-optimal learning of Deep Random Networks of Extensive-width

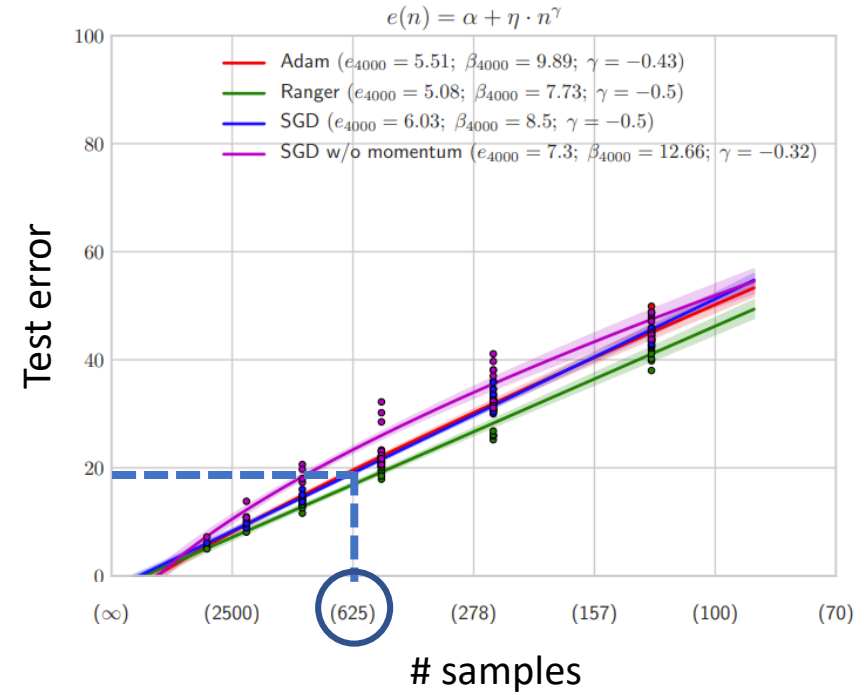
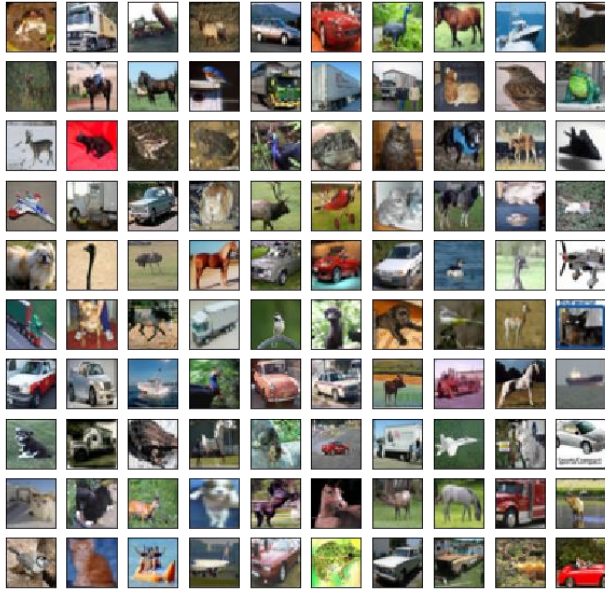
Hugo Cui, Florent Krzakala & Lenka Zdeborová

EPFL, Switzerland





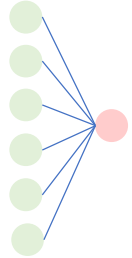
Question: *What is the best accuracy* one can achieve from 600 training samples?



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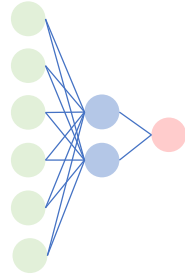
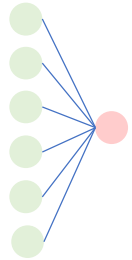
(Empirical) Answer: Probably $\approx 82\%$, using good networks.

Theoretical testbeds: *random neural networks*



Barbier et al, *Optimal errors and phase transitions in high-dimensional generalized linear models*, PNAS 2017

Theoretical testbeds: *random neural networks*

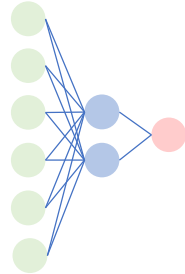
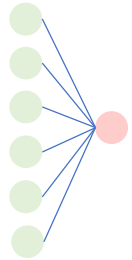


width \ll *dimension*

Barbier et al, *Optimal errors and phase transitions in high-dimensional generalized linear models*, PNAS 2017

Aubin et al, *The committee machine: Computational to statistical gaps*, NeurIPS 2019

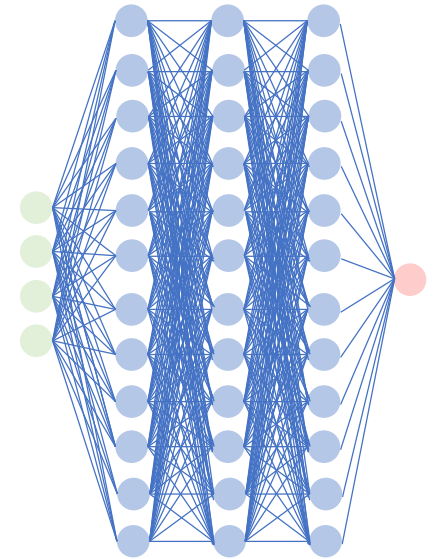
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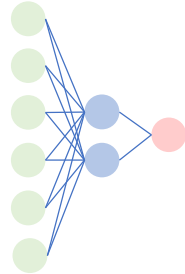
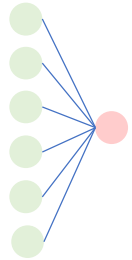
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width \gg *dimension*

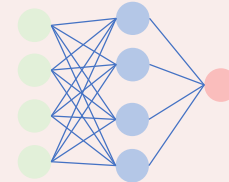
Neal, *Priors for infinite nets*, Uni. Toronto 1996
Williams, *Computing with infinite networks*, NeurIPS 1996
Lee et. al., *Deep Neural Networks as GPs*, ICLR 2018

Theoretical testbeds: *random neural networks*



width \ll *dimension*

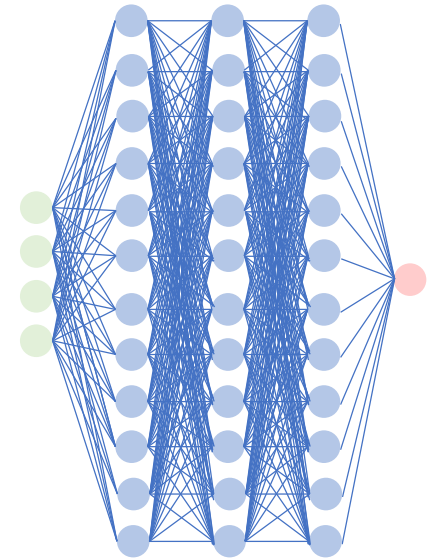
Barbier et al, *Optimal errors and phase transitions in high-dimensional generalized linear models*, PNAS 2017



width \sim *dimension*

Aubin et al, *The committee machine: Computational to statistical gaps*, NeurIPS 2019

Li and Sompolinsky, *Statistical Mechanics of Deep Linear Networks*, PRX 2020
Ariosto et al., *Statistical Mechanics of Deep Learning Beyond the Infinite Width limit*, 2023



width \gg *dimension*

Neal, *Priors for infinite nets*, Uni. Toronto 1996
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Lee et. al., *Deep Neural Networks as GPs*, ICLR 2018

(Data)

Gaussian data: $x \sim \mathcal{N}(0, \Sigma)$

(Data)

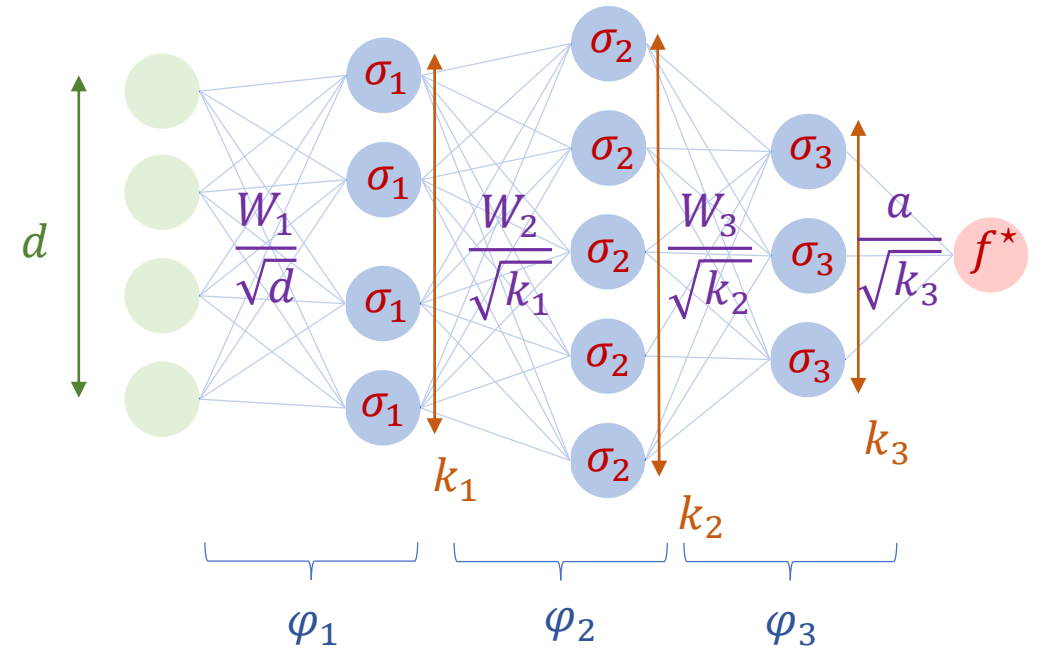
Gaussian data: $x \sim \mathcal{N}(0, \Sigma)$

(Target)

$$y^*(x) = f^* \left(\frac{a^\top}{\sqrt{k_L}} \varphi_L \circ \dots \circ \varphi_1(x) + \sqrt{\Delta} \xi \right)$$

with layers $\varphi_\ell(h) = \sigma_\ell \left(\frac{W_\ell}{\sqrt{k_{\ell-1}}} h \right)$

$$(W_\ell)_{ij} \sim \mathcal{N}(0, \Delta_\ell), \quad a_i \sim \mathcal{N}(0, \Delta_a)$$



(Data)

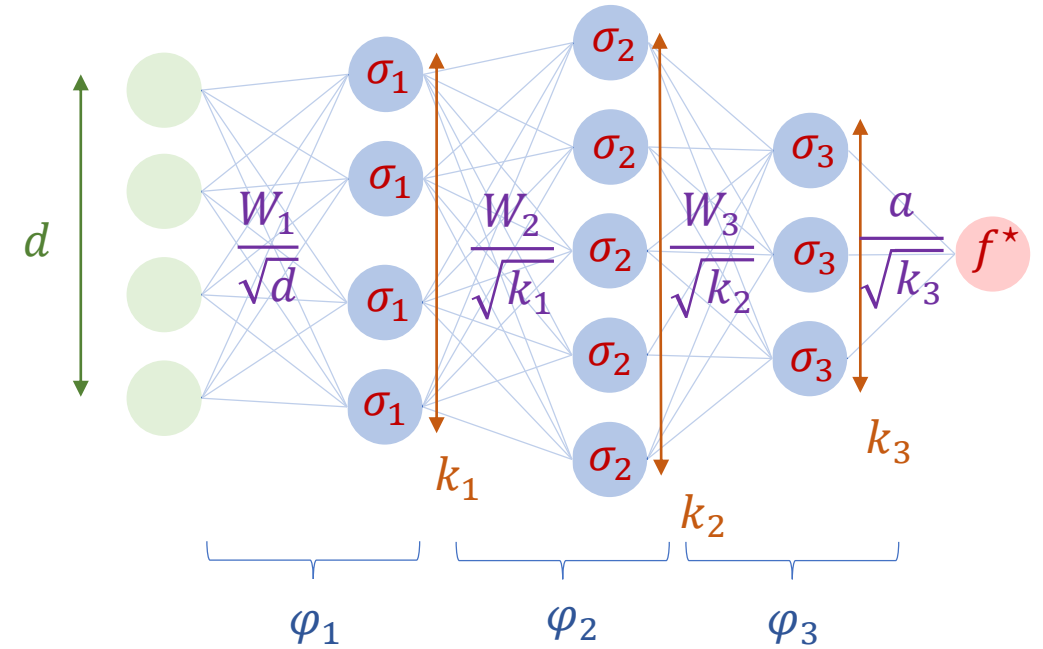
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(Train set)

Supervised learning with n i.i.d samples $\mathcal{D} = \{x^\mu, y^*(x^\mu)\}_{\mu=1}^n$

(Data)

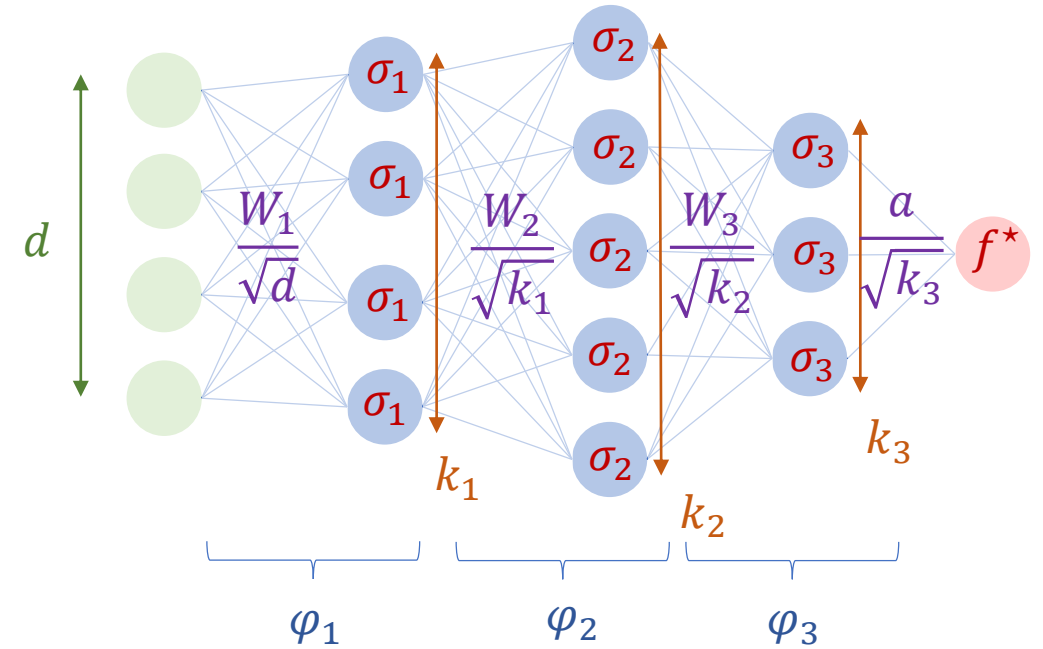
Gaussian data: $x \sim \mathcal{N}(0, \Sigma)$

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$$y^*(x) = f^* \left(\frac{a^\top}{\sqrt{k_L}} \varphi_L \circ \dots \circ \varphi_1(x) + \sqrt{\Delta} \xi \right)$$

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(Train set)

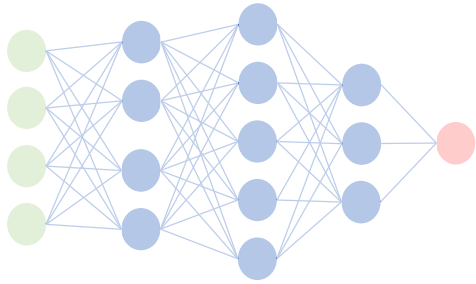
Supervised learning with n i.i.d samples $\mathcal{D} = \{x^\mu, y^*(x^\mu)\}_{\mu=1}^n$

Proportional extensive-width limit

$$n, d, k_1, \dots, k_L \rightarrow \infty$$

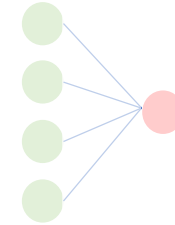
with

$$\alpha = \frac{n}{d}, \gamma_\ell = \frac{k_\ell}{d} = \mathcal{O}(1)$$



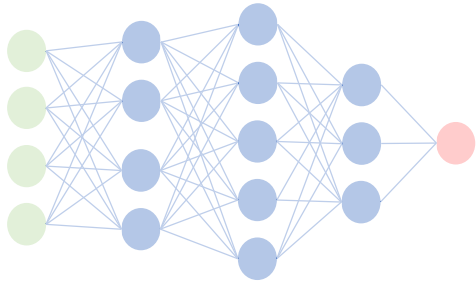
same Bayes optimal errors

\approx



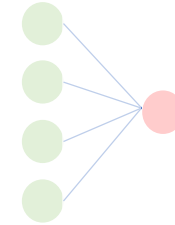
$$y^*(x) = f^* \left(\frac{a^\top}{\sqrt{k_L}} \varphi_L \circ \dots \circ \varphi_1(x) + \sqrt{\Delta} \mathcal{N}(0,1) \right)$$

$$y^{\text{eq}}(x) = f^* \left(\rho \frac{\theta^\top x}{\sqrt{d}} + \epsilon_r \mathcal{N}(0,1) \right)$$



same Bayes optimal errors

\approx



$$y^*(x) = f^* \left(\frac{a^\top}{\sqrt{k_L}} \varphi_L \circ \dots \circ \varphi_1(x) + \sqrt{\Delta} \mathcal{N}(0,1) \right)$$

$$y^{\text{eq}}(x) = f^* \left(\rho \frac{\theta^\top x}{\sqrt{d}} + \epsilon_r \mathcal{N}(0,1) \right)$$

ρ, ϵ_r depend on the architecture and activations of the original network.

Regression

$$\epsilon_{g,\text{reg}}^{\text{BO}} = \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \left(\Delta_a \left(\int z d\mu(z) \right) \prod_{\ell=1}^L \Delta_\ell - q \right) + \epsilon_r$$

$$q = \frac{1}{2} \int \frac{\alpha \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 z^2 \Delta_a^2 \prod_{\ell=1}^L \Delta_\ell^2}{\epsilon_{g,\text{reg}}^{\text{BO}} + \alpha \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 z \Delta_a \prod_{\ell=1}^L \Delta_\ell} d\mu(z).$$

Classification

$$\epsilon_{g,\text{class}}^{\text{BO}} = \frac{1}{\pi} \arccos \left[\frac{\sqrt{\prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 q}}{\sqrt{\Delta_a \int z d\mu(z) \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \Delta_\ell + \epsilon_r}} \right]$$

$$\left\{ \begin{array}{l} q = \int \frac{\hat{q} \Delta_a^2 \prod_{\ell=1}^L \Delta_\ell^2 z^2}{\hat{q} z \Delta_a \prod_{\ell=1}^L \Delta_\ell + 1} d\mu(z) \\ \hat{q} = \frac{2\alpha \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2}{\Delta_a \int z d\mu(z) \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \Delta_\ell + \epsilon_r - \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 q} \\ \int \frac{d\xi}{(2\pi)^{\frac{3}{2}}} \frac{2e^{-\frac{1}{2} \Delta_a \int z d\mu(z) \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \Delta_\ell + \epsilon_r + \frac{\prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 q}{\xi^2}}}{1 - \text{erf} \left(\frac{\prod_{\ell=1}^L \kappa_1^{(\ell)} \sqrt{q} \xi}{\sqrt{2 \left(\Delta_a \int z d\mu(z) \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \Delta_\ell + \epsilon_r - \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 q \right)}} \right)} \end{array} \right.$$

Regression

$$\epsilon_{g,\text{reg}}^{\text{BO}} = \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \left(\Delta_a \left(\int z d\mu(z) \right) \prod_{\ell=1}^L \Delta_\ell - q \right) + \epsilon_r$$

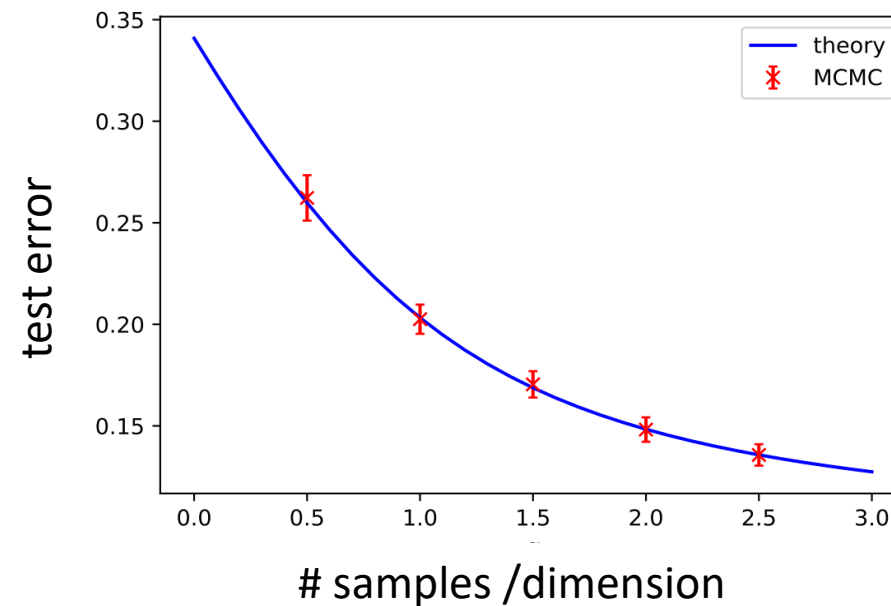
$$q = \frac{1}{2} \int \frac{\alpha \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 z^2 \Delta_a^2 \prod_{\ell=1}^L \Delta_\ell^2}{\epsilon_{g,\text{reg}}^{\text{BO}} + \alpha \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 z \Delta_a \prod_{\ell=1}^L \Delta_\ell} d\mu(z).$$

Classification

$$\epsilon_{g,\text{class}}^{\text{BO}} = \frac{1}{\pi} \arccos \left[\frac{\sqrt{\prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 q}}{\sqrt{\Delta_a \int z d\mu(z) \prod_{\ell=1}^L (\kappa_1^{(\ell)})^2 \Delta_\ell + \epsilon_r}} \right]$$

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depth = 2, $\sigma = \text{ReLU} - 1 / \sqrt{2\pi}$

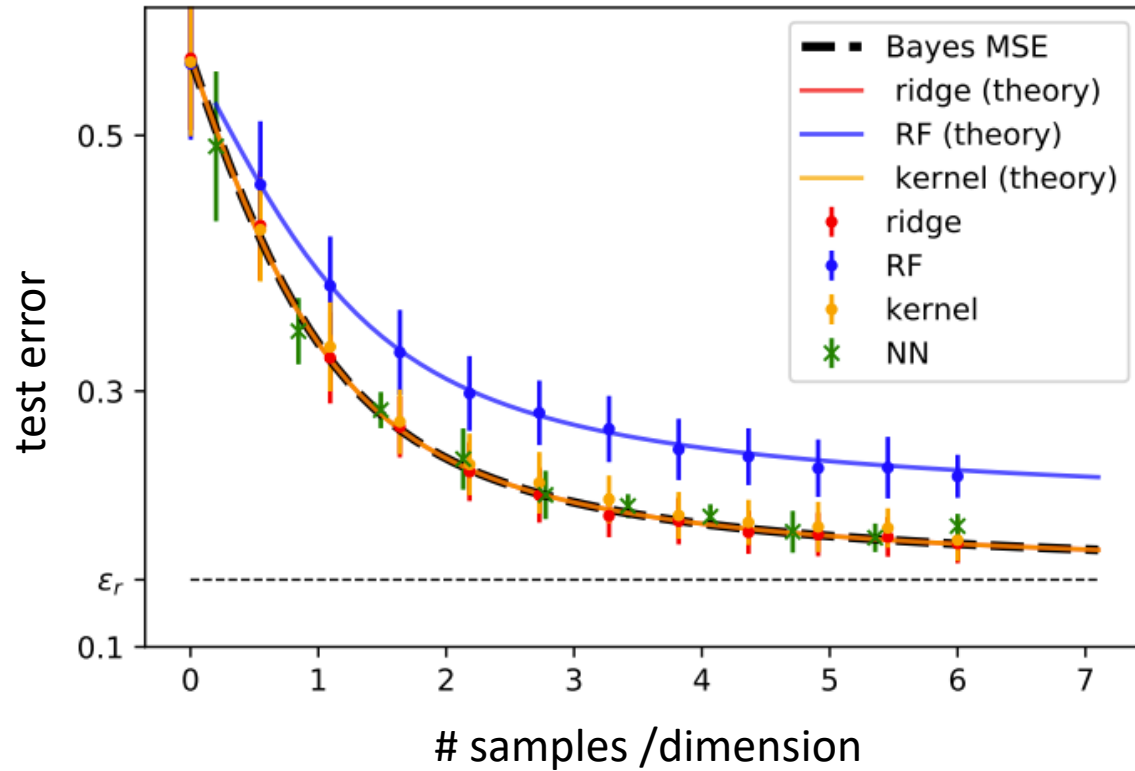


✓ **Q1.** Can one provide a sharp asymptotic characterization of the Bayes-optimal error?

Q2. How do the test errors achieved by ERM algorithms in practice compare?

Regression

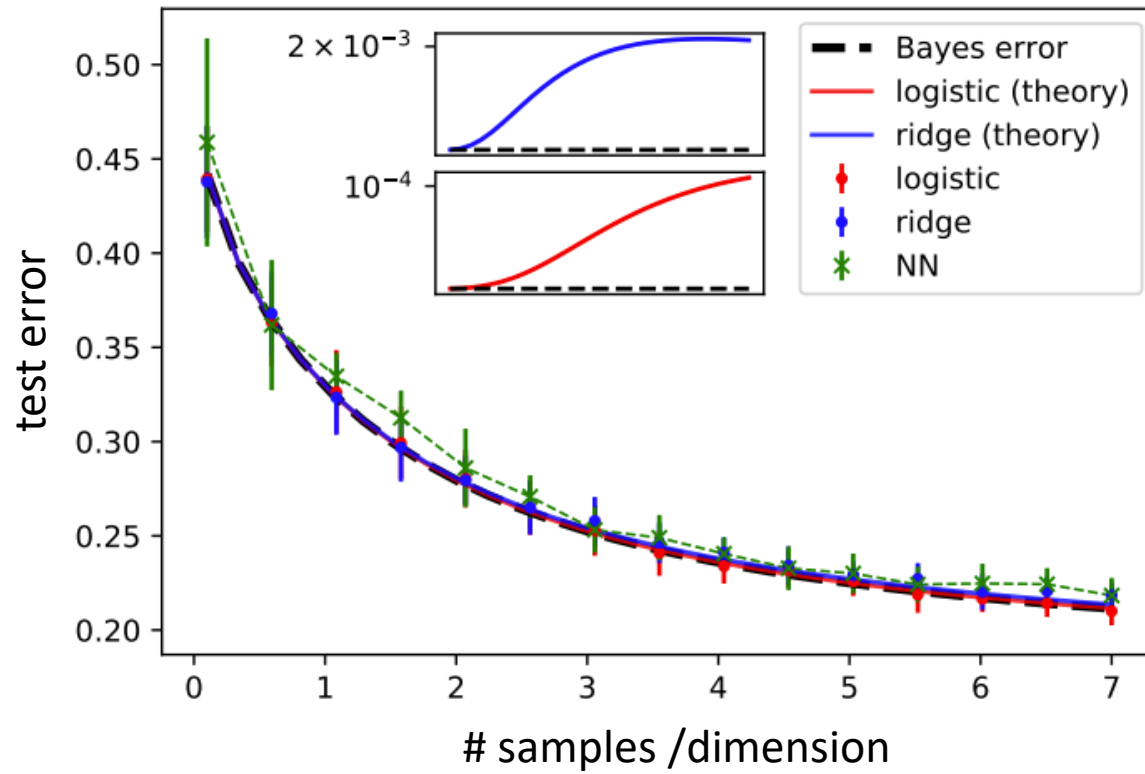
depth = 3, $\sigma = \tanh$



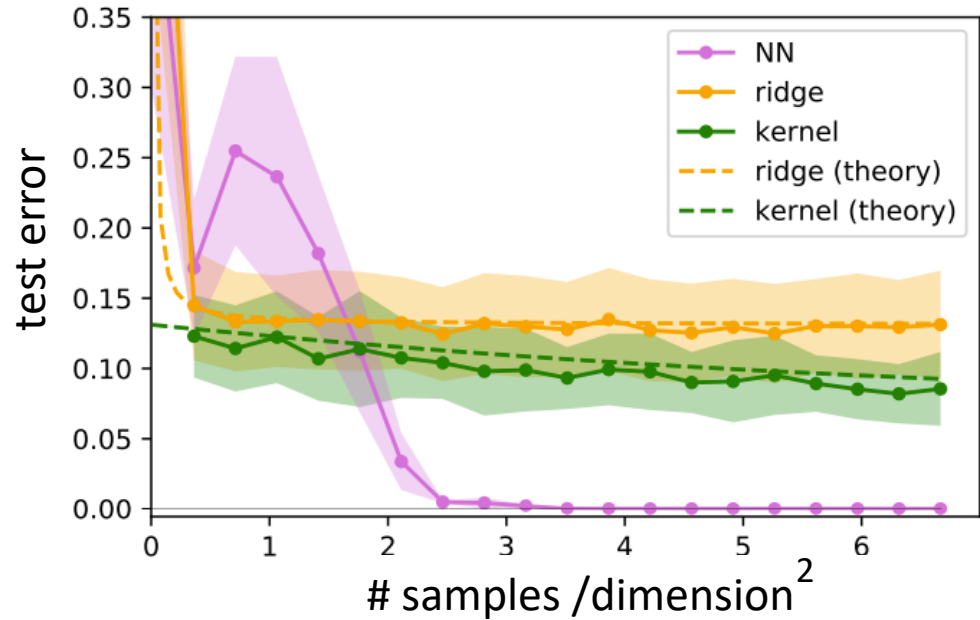
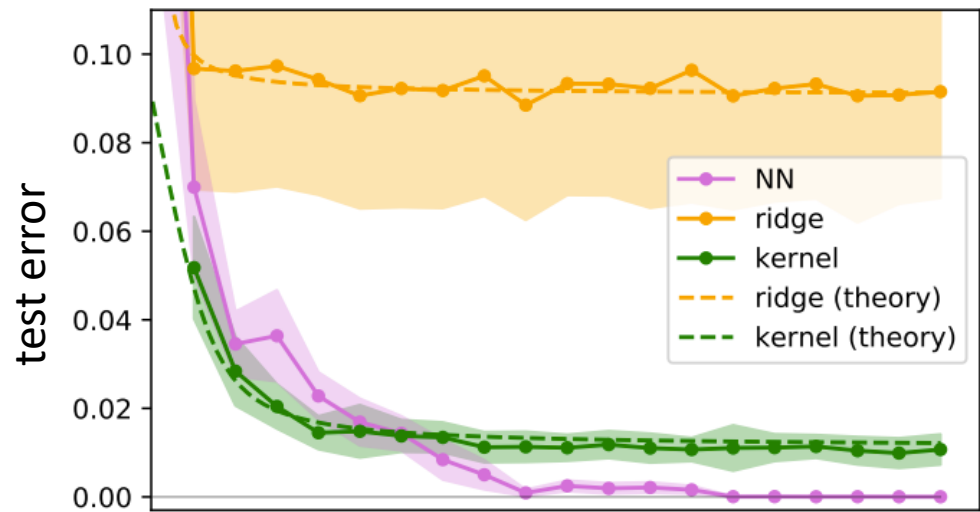
Optimally regularized ridge regression and kernel regression *are Bayes optimal*.

Classification

depth = 3, $\sigma = \tanh$



Optimally regularized logistic and ridge classification *are close to Bayes optimal*.



When $n \sim d^2$, *higher-order statistics are learnt*, the Gaussian equivalences break down.

Takeaways:

- We conjecture closed-form formulas for the Bayes-optimal test errors when learning data generated by a deep non-linear random network.
- This optimal error is achieved by very simple ERM methods.

Challenge /Future work:

There is a need for a theory of finite-width architectures in *super linear regimes*.

Thank you for your attention !

See you at posters:

221 on Thu. 10.30 (*this work*)

814 on Wed 14.00 (*learning with deep random nets*)